

Methanol
VLSI



Material No.: 5370-05
Batch No.: 0000109116
Manufactured Date: 2015/04/08
Retest Date: 2020/04/06

Certificate of Analysis

Test	Specification	Result
Assay (CH ₃ OH) (by GC)	>= 99.9 %	100.0
Color (APHA)	<= 10	5
Acidity (µeq/g)	<= 0.3	0.2
Alkalinity (µeq/g)	<= 0.1	0.1
Residue after Evaporation	<= 5 ppm	< 1
Water (H ₂ O)(by Karl Fischer titrn)	<= 0.05 %	0.01
Solubility in H ₂ O	Passes Test	PT
Arsenic and Antimony (as As)	<= 10 ppb	< 10
Chloride (Cl)	<= 0.2 ppm	< 0.1
Heavy Metals (as Pb)	<= 100 ppb	< 100
Phosphate (PO ₄)	<= 0.3 ppm	< 0.3
Trace Impurities – Aluminum (Al)	<= 50.0 ppb	< 5.0
Trace Impurities – Barium (Ba)	<= 20.0 ppb	< 1.0
Trace Impurities – Boron (B)	<= 10.0 ppb	< 5.0
Trace Impurities – Cadmium (Cd)	<= 20.0 ppb	< 1.0
Trace Impurities – Calcium (Ca)	<= 50.0 ppb	1.8
Trace Impurities – Chromium (Cr)	<= 20.0 ppb	< 1.0
Trace Impurities – Cobalt (Co)	<= 20.0 ppb	< 1.0
Trace Impurities – Copper (Cu)	<= 10.0 ppb	< 1.0
Trace Impurities – Gallium (Ga)	<= 50.0 ppb	< 1.0
Trace Impurities – Germanium (Ge)	<= 50.0 ppb	< 10.0
Trace Impurities – Gold (Au)	<= 20.0 ppb	< 5.0
Trace Impurities – Iron (Fe)	<= 50.0 ppb	2.2
Trace Impurities – Lead (Pb)	<= 50.0 ppb	< 10.0

Test	Specification	Result
Trace Impurities – Lithium (Li)	<= 50.0 ppb	< 1.0
Trace Impurities – Magnesium (Mg)	<= 50.0 ppb	< 1.0
Trace Impurities – Manganese (Mn)	<= 10.0 ppb	< 1.0
Trace Impurities – Nickel (Ni)	<= 10.0 ppb	< 5.0
Trace Impurities – Potassium (K)	<= 50.0 ppb	< 10.0
Trace Impurities – Silicon (Si)	<= 50.0 ppb	< 10.0
Trace Impurities – Silver (Ag)	<= 20.0 ppb	< 1.0
Trace Impurities – Sodium (Na)	<= 50.0 ppb	< 5.0
Trace Impurities – Strontium (Sr)	<= 10.0 ppb	< 1.0
Trace Impurities – Tin (Sn)	<= 50.0 ppb	< 10.0
Trace Impurities – Titanium (Ti)	<= 20.0 ppb	< 1.0
Trace Impurities – Zinc (Zn)	<= 50.0 ppb	< 1.0
Particle Count – 0.5 µm and greater	<= 50 par/ml	13
Particle Count – 1.0 µm and greater	<= 8 par/ml	6

For Microelectronic Use

Reported value is the average of all samples counted for this lot number, with no individual sample value exceeding the specification.

Country of Origin: US
Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001:2008, 14001:2004, FSSC 22000
 Paris, KY 9001:2008
 Mexico City, Mexico 9001:2008
 Deventer, The Netherlands 9001:2008, 14001:2004, 13485:2003
 Gliwice, Poland 9001:2008, 17025:2005
 Selangor, Malaysia 9001:2008
 Dehradun, India, 9001:2008, 14001:2004, 13485:2003
 Mumbai, India, 9001:2008, 17025:2005
 Panoli, India 9001:2008



Richard M Siberski
 Vice President Global Quality